

MOS FIELD EFFECT TRANSISTOR μ PA1706

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

This product is N-Channel MOS Field Effect Transistor designed for DC/DC Converters and power management applications of notebook computers.

FEATURES

• Super low on-resistance

RDS(on)1 = $5.8 \text{ m}\Omega$ TYP. (VGS = 10 V, ID = 7.0 A)

 $R_{DS(on)2} = 7.0 \text{ m}\Omega \text{ TYP. (Vgs} = 4.5 \text{ V, Ip} = 7.0 \text{ A)}$

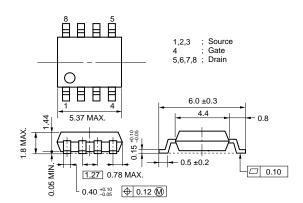
RDS(on)3 = 8.0 m Ω TYP. (Vgs = 4.0 V, ID = 7.0 A)

- Low Ciss : Ciss = 3000 pF TYP.
- Built-in G-S protection diode
- Small and surface mount package (Power SOP8)

ORDERING INFORMATION

PART NUMBER	PACKAGE
μPA1706G	Power SOP8

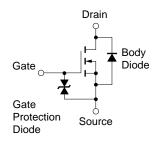
PACKAGE DRAWING (Unit: mm)



EQUIVALENT CIRCUIT

ABSOLUTE MAXIMUM RATINGS (TA = 25 °C, All terminals are connected)

Drain to Source Voltage Note1	Voss	30	V
Gate to Source Voltage Note2	Vgss	±20	V
Drain Current (DC)	ID(DC)	±13	Α
Drain Current (pulse) Note3	ID(pulse)	±52	Α
Total Power Dissipation (T _A = 25 °C) Note4	Рт	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to + 150	°C



Notes 1. Vgs = 0 V

- 2. VDS = 0 V
- **3.** PW \leq 10 μ s, Duty cycle \leq 1 %
- 4. Mounted on ceramic substrate of 1200 mm² x 0.7 mm

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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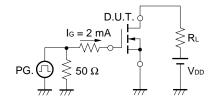
ELECTRICAL CHARACTERISTICS (TA = 25 °C, All terminals are connected)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, ID = 7.0 A		5.8	7.8	mΩ
	RDS(on)2	Vgs = 4.5 V, ID = 7.0 A		7.0	10.0	mΩ
	RDS(on)3	Vgs = 4.0 V, ID = 7.0 A		8.0	12.0	mΩ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 7.0 A	10	22		S
Drain Leakage Current	Ipss	V _{DS} = 30 V, V _{GS} = 0 V			10	μΑ
Gate to Source Leakage Current	lgss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
Input Capacitance	Ciss	Vps = 10 V		3000		pF
Output Capacitance	Coss	V _{GS} = 0 V		950		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		380		pF
Turn-on Delay Time	td(on)	ID = 7.0 A		40		ns
Rise Time	tr	V _{GS(on)} = 10 V		220		ns
Turn-off Delay Time	t _{d(off)}	Vpp = 15 V		140		ns
Fall Time	tf	$R_G = 10 \Omega$		90		ns
Total Gate Charge	QG	ID = 13 A		56		nC
Gate to Source Charge	Qgs	V _{DD} = 24 V		9		nC
Gate to Drain Charge	Q _{GD}	V _{GS} = 10 V		14		nC
Body Diode Forward Voltage	VF(S-D)	IF = 13 A, VGS = 0 V		0.8		V
Reverse Recovery Time	trr	IF = 13 A, VGS = 0 V		43		ns
Reverse Recovery Charge	Qrr	di/dt = 100A/μs		50		nC

TEST CIRCUIT 1 SWITCHING TIME

PG. $\bigcap_{R_G} R_G = 10 \Omega$ $V_{GS} \bigvee_{Wave Form} V_{GS} \bigvee_{Wave Form} V_{GS} \bigvee_{UD} \bigvee_{Wave Form} V_{GS} \bigvee_{UD} \bigvee_{$

TEST CIRCUIT 2 GATE CHARGE

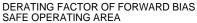


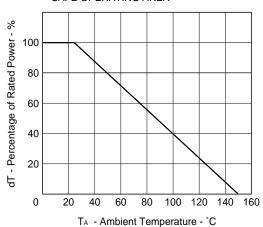
90 %

90 %

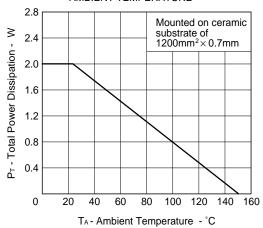
10 %

TYPICAL CHARACTERISTICS (TA = 25°C)

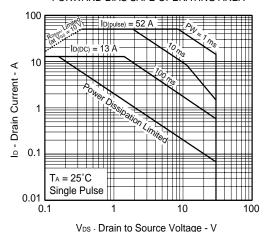




TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE

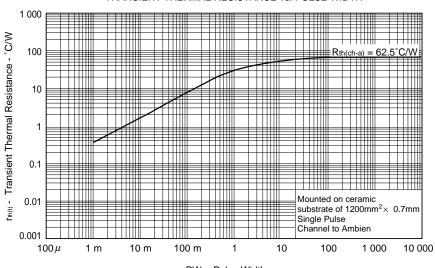


FORWARD BIAS SAFE OPERATING AREA



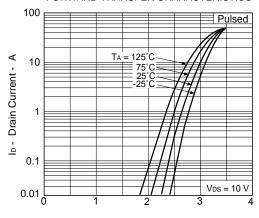
Remark Mounted on ceramic substrate of 1200 $\text{mm}^2 \times$ 0.7 mm

TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



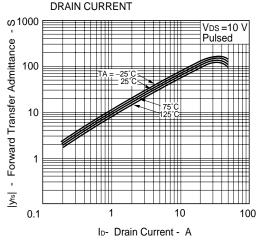
PW - Pulse Width - s

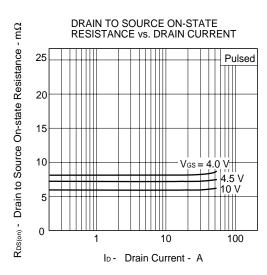
FORWARD TRANSFER CHARACTERISTICS



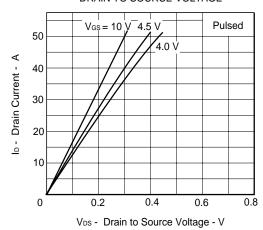
V_{GS} - Gate to Source Voltage - V

FORWARD TRANSFER ADMITTANCE vs.

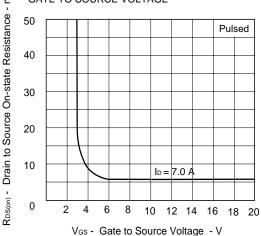




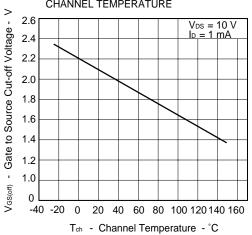
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

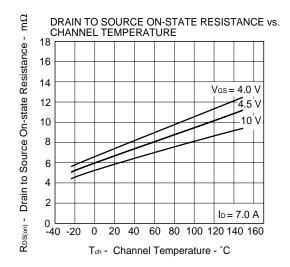


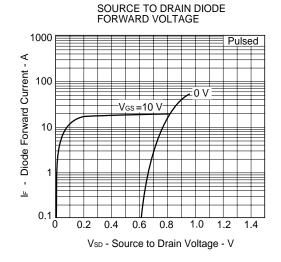
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

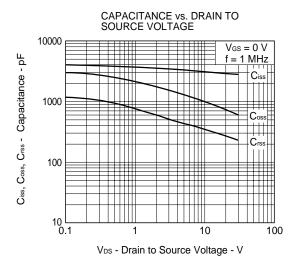


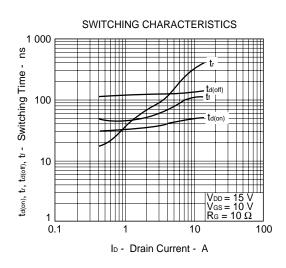
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

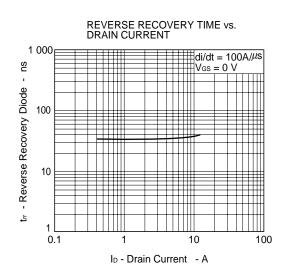


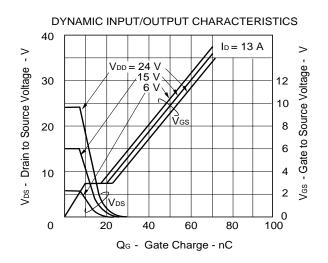












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